

**Search Notes**

Application/Control No.

10/801,177

Examiner

Y Quach Lee

Applicant(s)/Patent under  
Reexamination

BELLIVEAU, RICHARD S.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	184 187 188 202 203 232 238	2/22/2005	YMY
	240 250 285		
	286 288		
	800		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	2/22/2005	YMY